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La Simulation matériel et logiciel dans un système de test automatique



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The Marvin Group



 **MARVIN TEST
SOLUTIONS**

M L S
MARVIN LAND SYSTEMS

FLYER
DEFENSE



Aircraft Armament Equipment

- Bomb Racks
- Ejector Racks
- Missile Rail Launchers
- Multiple Carriage Systems
- Pylons



Test & Support Systems

- Armament and munition Test Sets
- SMS Test Sets
- Flightline, I-level, and depot-level testers
- Production test equipment



Land Systems

- Mission Critical Equipment Trailers and Shelters
- Vehicle Environmental Systems
- Auxiliary Power Units
- Weapons Stations



Tactical Vehicles

- Light Strike Armored or Unarmored
- Rescue and Personnel Recovery
- Reconnaissance
- Anti-tank



Machining Tooling Prototype

- Armored Personnel Carriers
- MRAP
- Abrams
- Bradley
- FMTV
- JLTV
- Stryker

Total Solutions & Support Capabilities including repair, overhaul,
upgrades, maintenance & training

Les clients

PAGE 3

Military

U.S. Armed Forces and our allies



Raytheon



NORTHROP GRUMMAN



Eltit Systems

Aerospace

U.S. and Foreign Aerospace Firms

THALES

SNCF

AIRBUS

QUALCOMM®

HOLT
INTEGRATED CIRCUITS

ON
ON Semiconductor

HALLIBURTON

AgustaWestland
A Finmeccanica Company

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TECHNOLOGIES**

MICROCHIP

**FAIRCHILD
SEMICONDUCTOR®**

ALSTOM

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Nos Solutions



Solutions de Test Flightline

MTS-3060 SmartCan™



MT1888



MT3045 IRIS



AN/TMS-205



- F-16
- TA-50
- F-15
- AH-64
- F-35
- AH-1
- F-22
- UH-60
- A-10
- Tigre

Solutions de Test Niveau intermédiaire

MTS-916



MTS-206



MTS-209



MTS-235



- F-16
- F-15
- F-35
- Supporte autres avions et munitions

Nos Solutions (cont.)

■ Solutions de Test Dépôt



- F-16
- F-15
- F-35
- Supporte autres avions et munitions

■ Solutions de Test pour l'industrie



- Avionique, Défense , Semi-conducteurs et autres applications de test fonctionnel

Full Spectrum Product Portfolio

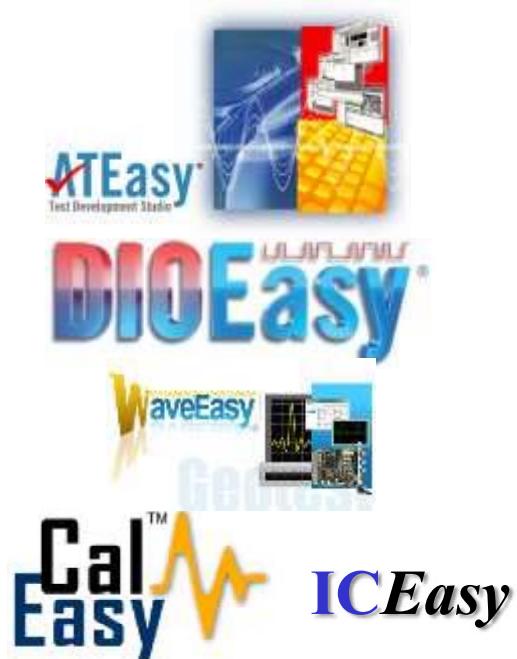
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Supporting our customers with innovative products & systems

Hardware Building Blocks



Software Building Blocks



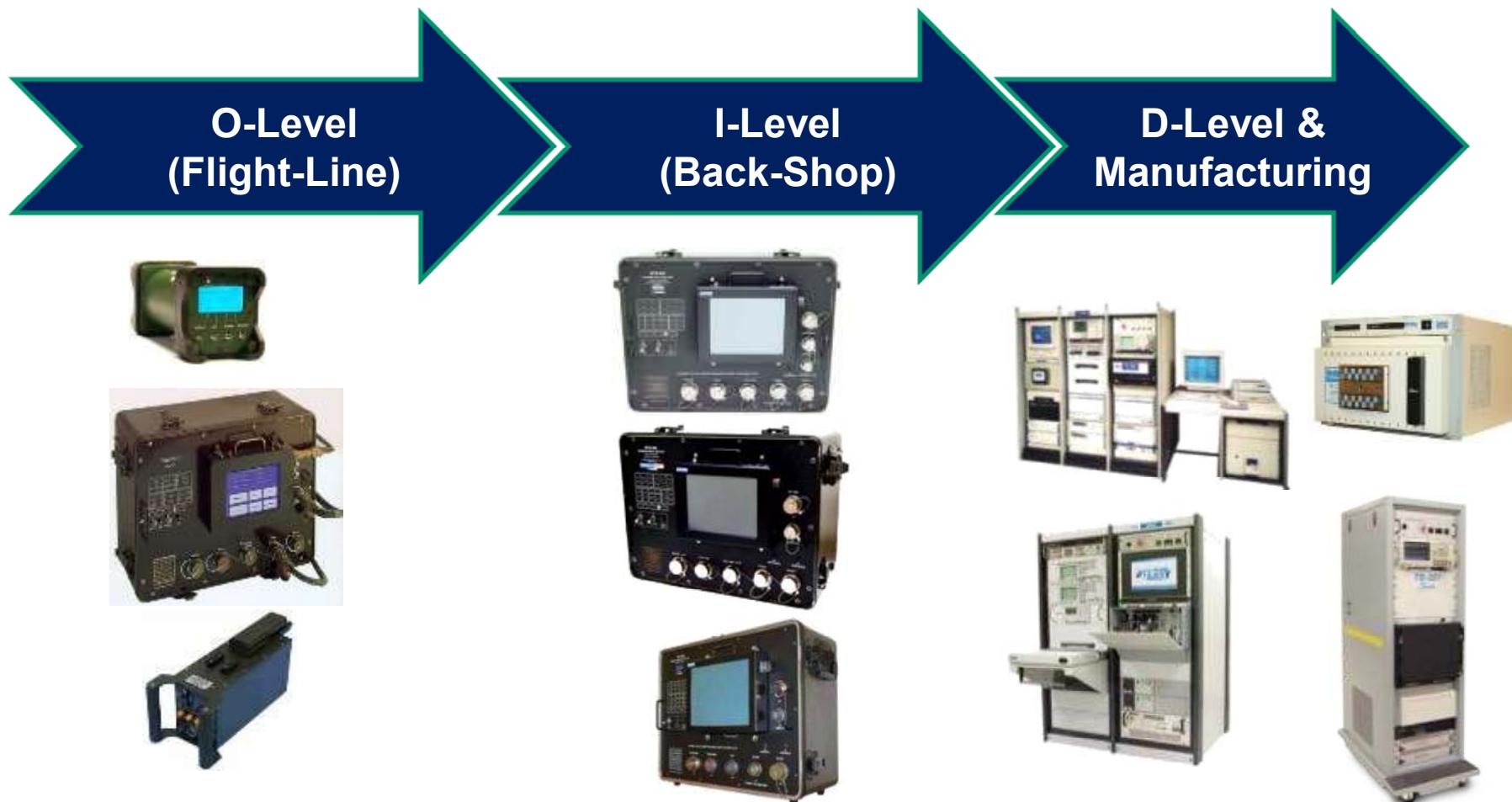
Preconfigured Systems & Subsystems



Vertical Integration Offers a Range of Test Solutions

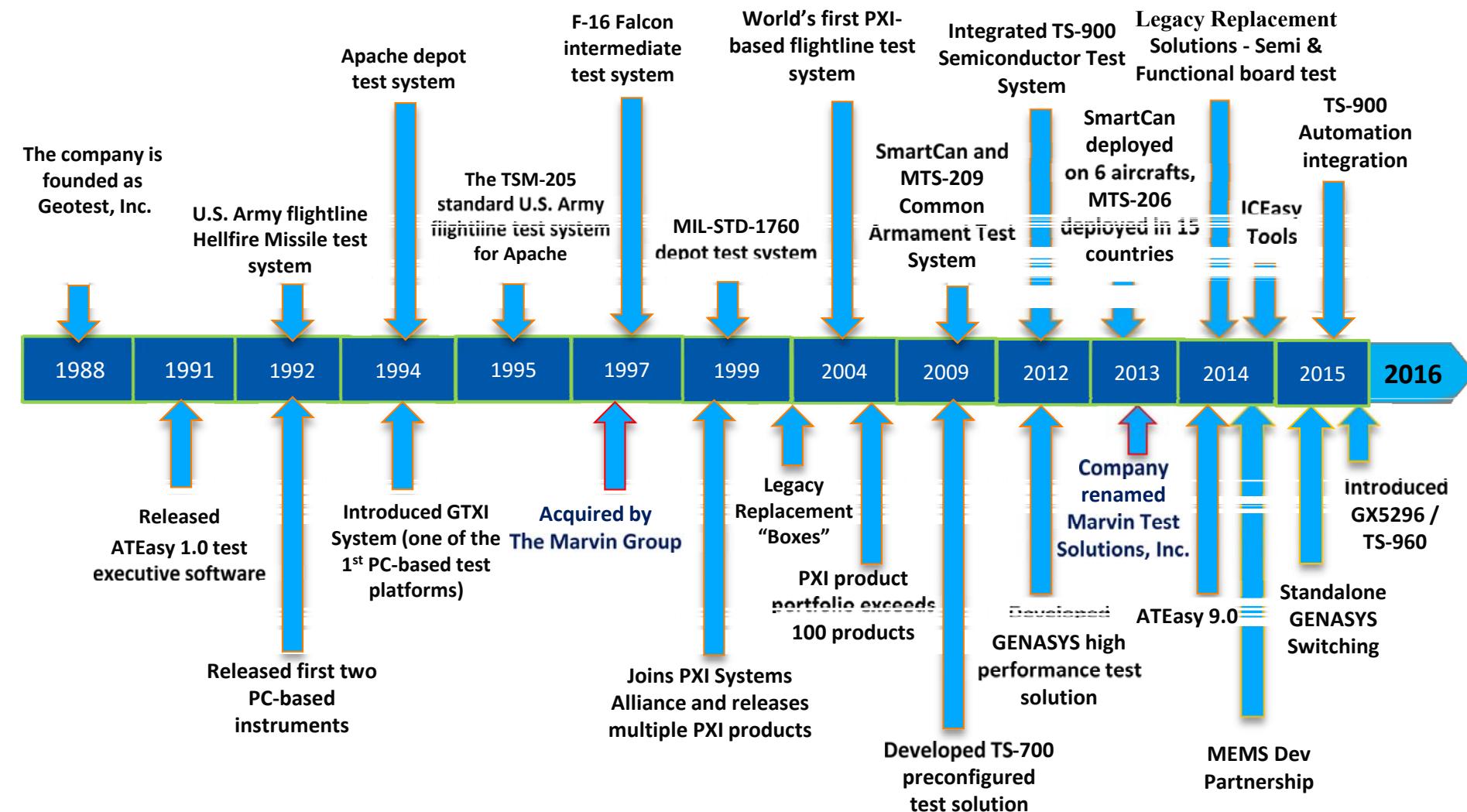
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Supporting our customers with innovative Turn-Key test solutions



Over 25 Years of Innovative Test Systems

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PXI Products

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“Integrated” PXI Test Systems

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TS-700 Series

Bench-top PXI-based
testers for digital, avionics
and mixed-signal test
applications



TS-323 GENASYS

High performance mixed
signal functional test system
for production and depot
applications



MTS-207 Platform

Ultra-rugged PXI platform
for demanding field and
flightline applications



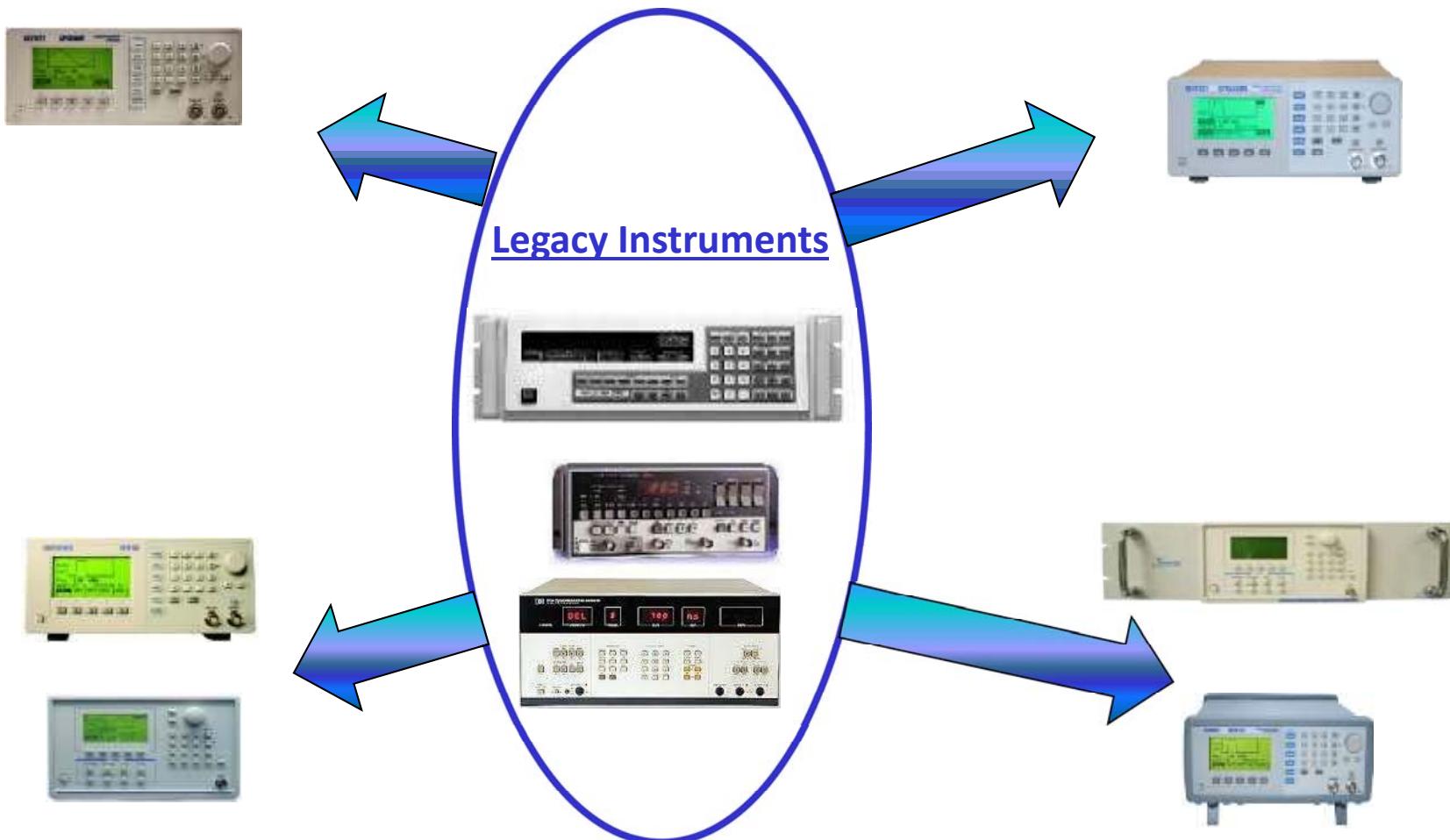
TS-900 Series

High-performance
semiconductor test
system



Legacy Replacement Products

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Software Tools Make A.T.E. Easy

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An analog waveform development tool

Calibration and Verification software

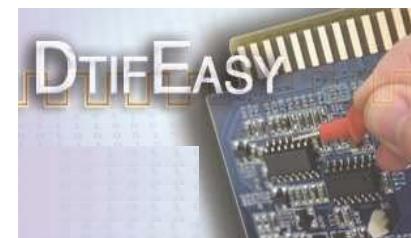


An integrated, open-architecture Test Executive and Development Suite for test applications deployed since 1991



A digital vector editor for all MTS' high-performance digital I/O products

A LASAR post-processor test and troubleshooting tool



La Simulation matériel et logiciel dans un système de test automatique

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La simulation nécessite l'exécution de l'application avec un sous-ensemble de l'instrumentation ou sans instrumentation et avec ou sans l'unité sous test (UUT)

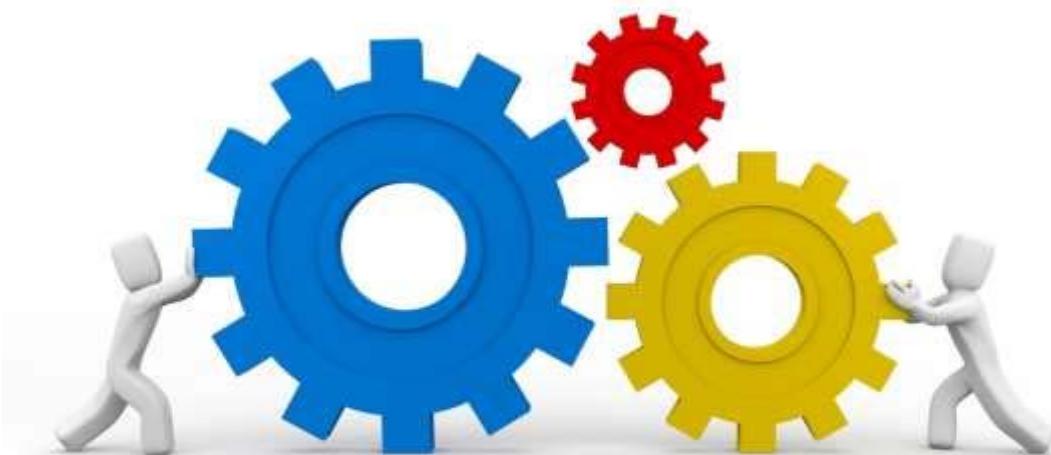
La solution présentée expose en détail la mise en œuvre d'un système de simulation qui est créé par l'amélioration du moteur d'exécution de l'application qui fait partie d'un environnement logiciel de développement d'applications de test automatique ATEasy



What is Test System Simulation?

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Simulation is the imitation of the operation of a test system over time, including the system instruments, the test system test application and the UUT.



Why do we need to simulate?

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- Develop, Debug and Run, Test your application on your desktop with no hardware (Instruments or UUT)
 - System time, Better resource utilization
 - Engineering time – faster development and debugging cycles
 - Short time to market
- Code and application robustness
 - Create test/use cases, debug code and create more robust app
 - Trace and analyze performance

Features Required for Successful Simulation

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- Run your application with or without instruments
- Run your application without UUT
- Run your application with or without hardware interface (i.e. GPIB, VXI, LXI, USB, PXI, RS232, etc)
- Redirect Procedures to Simulation Code
- Minimal Code changes because of simulation
- Access and Perform Everything:
 - Get/Set Parameters/Return Value, Call Stack, variables, tests, etc.
 - Execute code

What Currently Available?

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- IVI Simulation
 - Pretty limited in Scope – only Driver
 - No UUT, software, UUT simulation
 - Only IVI Driver, Driver Vendor must supply Simulation driver to support it
- Other...
 - Custom implementation ...

..... AND.....

- ❖ *ATEasy* is a full test development solution that includes a test executive and software application development environment, all in one application suite
- ❖ *ATEasy* is a development environment that combines the structure of **ATLAS**, the ease of Microsoft **Visual Basic** with the flexibility of Microsoft **Visual C++** into one easy-to-use integrated package



1. Framework driven:

- Streamline, Placeholder for everything
- Defined process for editing, running, debugging

2. A Test Engineer's Language:

- Test Technicians, Programmers and EE
- Instrument and Interface Interchangeability
- Self Documented, TRD oriented and easy to read (Commands)

3. Open Architecture

- Integrates with software standards and tools (DLL, DDE, Com/ActiveX, .NET, C, Function Panel drivers/LabWindows CVI, IVI & VISA, LabView , HTML, Source Control, ATML...)
- Supports for all standard control interfaces: (Serial, GPIB, VXI, USB, PC/PXI, TCP/IP, LXI...)

4. Backwards compatibility

- Any ATEasy version can open and use v1.0 files – programs, systems, and drivers
- Expandable File Format for drivers, system, programs; project format has not changed since v4.0

5. RAD (Rapid Application Development) tool

- Dolt!, TestIt!, TaskIt!, FormIt!, LoopIt!, ProgramIt!
- Shortens development cycle for editing, compiling running, debugging

6. Complete, integrated environment

- Test Executive integrated into the development environment
- Minimal external tools required, simplifies setup and deployment

7. Built-in Application Builder generates Royalty-Free run-time executables (.EXE files) and libraries (.DLL)

ATEasy's Key Product Features (cont'd)

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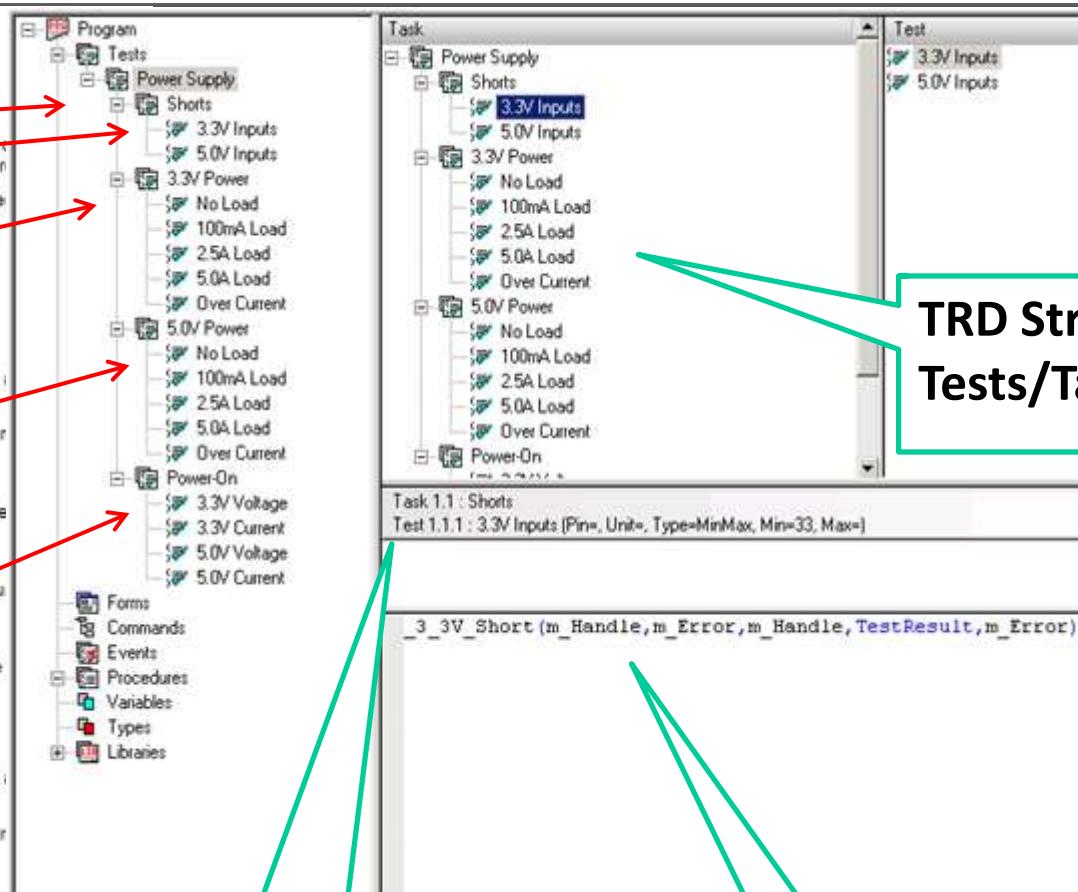
8. **Test Executive, Profile** offers full control of test execution, sequencing, test conditions, and data logging
9. **Integral Fault Analysis**
10. **Multiple UUT Testing** (Parallel or Sequential)
11. **Users & Groups based privileges** - Can be customized without writing additional code, menus, toolbar, options, debugging level
12. **Visual Basic-like forms**, menus and controls.
13. Connectivity with many **Source Controls Providers** and built in configuration management tools
14. **Simulation** – ATEasy offers full support for simulation: Instrument (no hardware), Software, UUT, and more

ATEasy TRD Structure

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UUT Power Supply Test

1. **Power Supply Test:** Validate the operation of each power module prior to UUT test. For each test, verify the Go/NoGo status of the test and, where applicable, run the associated self-test.
 - 1.1. **Shorts Test:** Verifies that each UUT power supply input is not shorted.
 - 1.1.1. **3.3V Inputs:** Pass Criteria: $33\text{ Ohms} \leq \text{Measured Value}$
 - 1.1.2. **5.0V Inputs:** Pass Criteria: $33\text{ Ohms} \leq \text{Measured Value}$
 - 1.2. **3.3V Power Tests:** Verify 3.3V regulation under various loads.
 - 1.2.1. **No Load:** Program the power supply to 3.3V and measure into load. Pass criteria: $3.2V \leq \text{Measured Value} \leq 3.4V$
 - 1.2.2. **Minimum Load:** Program the power supply to 3.3V and measure into 100mA load applied. Pass criteria: $3.15V \leq \text{Measured Value} \leq 3.4V$
 - 1.2.3. **Nominal Load:** Program the power supply to 3.3V and measure into 2.5A load applied. Pass criteria: $3.10V \leq \text{Measured Value} \leq 3.4V$
 - 1.2.4. **Maximum Load:** Program the power supply to 3.3V and measure into 5.0A load applied. Pass criteria: $3.10V \leq \text{Measured Value} \leq 3.4V$
 - 1.2.5. **Over-Current:** Program the power supply to 3.3V and measure into 5.0A load applied. Pass criteria: Power supply over-current indicator set
 - 1.3. **5.0V Power Tests:** Verify 5.0V regulation under various loads.
 - 1.3.1. **No Load:** Program the power supply to 5.0V and measure into load. Pass criteria: $4.9V \leq \text{Measured Value} \leq 5.25V$
 - 1.3.2. **Minimum Load:** Program the power supply to 5.0V and measure into 100mA load applied. Pass criteria: $4.85V \leq \text{Measured Value} \leq 5.25V$



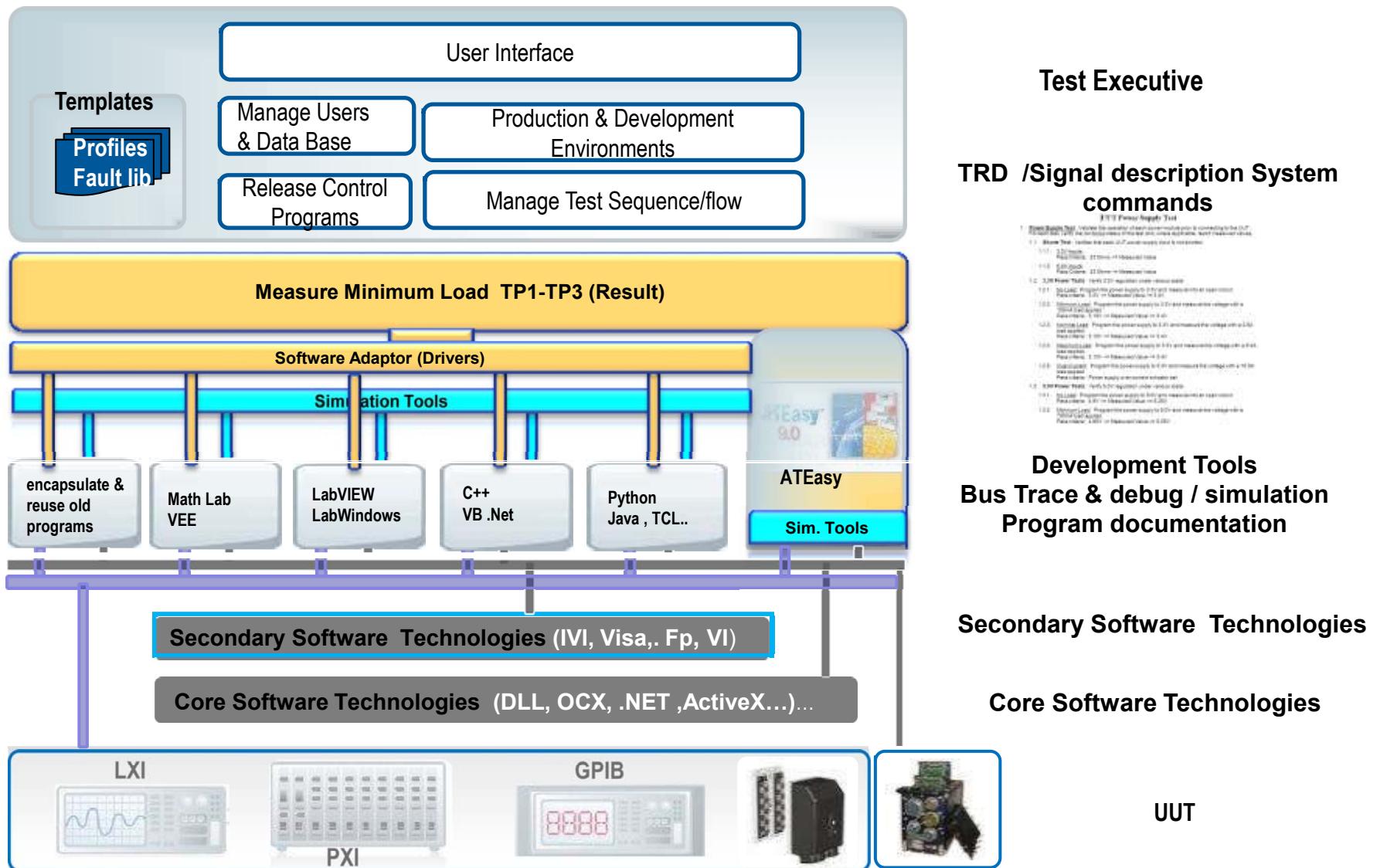
Test Properties

Test Code

The Marvin Group

Incorporation of multiple Software technologies

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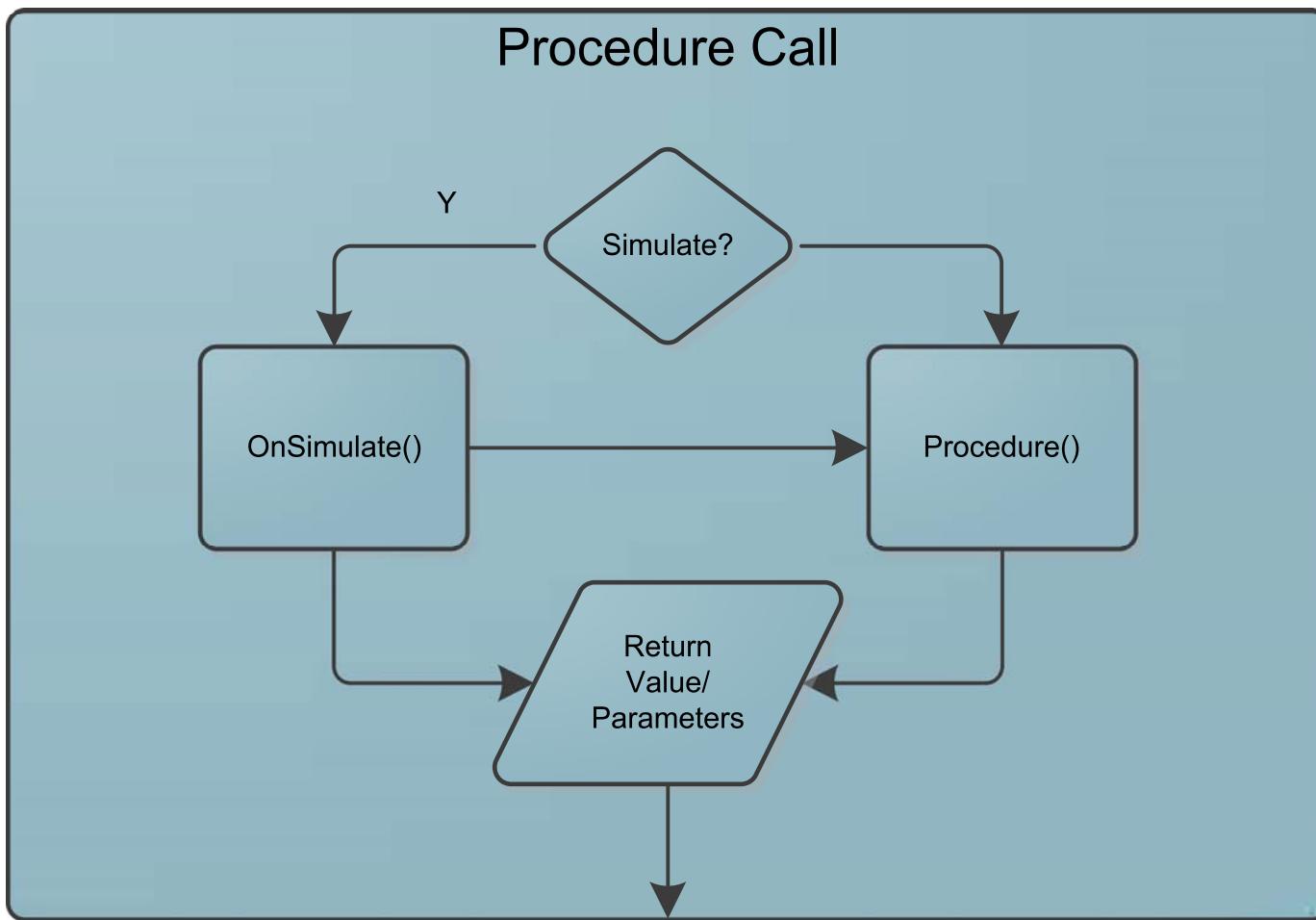
How we Did It? (ATEasy Implementation)

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- Set Simulation mode:
 - `App.Simulate=True`, Command line,
- Select Procedure to Simulate:
 - `SetSimulateProcedures()`:
 - module, sub-module, wildcard, individual
 - Procedure, IOTable, DLL
 - `GetSimulateParameters()`, `GetCaller()`, Test
- Event occurs when simulated procedure is called
 - `OnSimulate(sModule, proc, penReturn): Any`

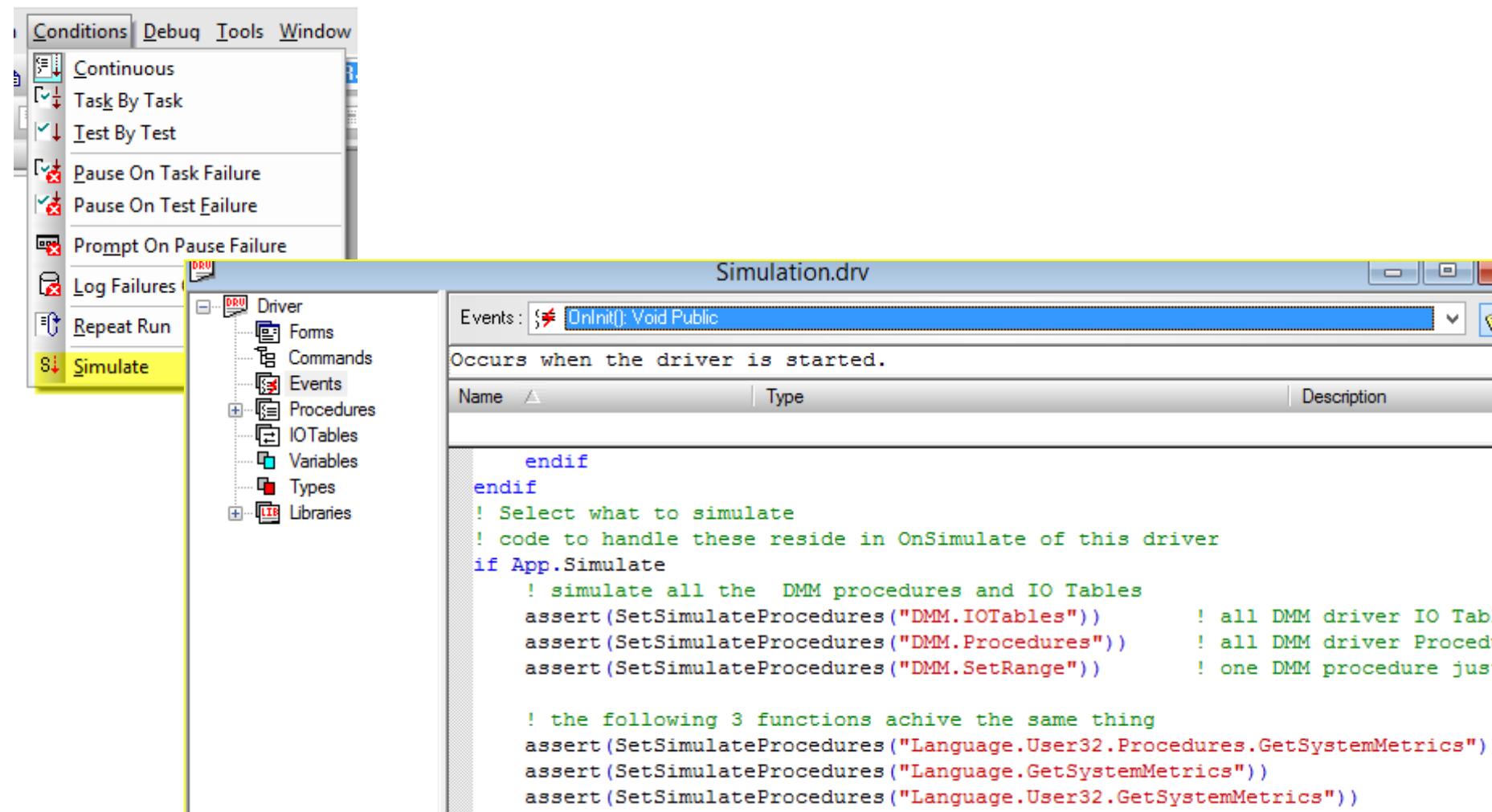
Simulation Procedure Call

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Simulation in Action - Setup

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Simulation In Action - Implementation

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The screenshot shows the Marvin Test Solutions software interface. On the left, the project tree for "Simulation.prg" is visible, containing "Program", "Tests" (with "DMM Tests" expanded), "Forms", "Commands", "Events", "Procedures", "Variables", "Types", and "Libraries". The "DMM Tests" folder contains a single test named "Measure VDC". The main workspace displays the test code:

```
Task 1 : DMM Tests
Test 1.1 : Measure VDC (Pin=P1-11, Unit=Volt, Type=MinMax)
! ATEasy Simulation Example
! Take a look at the SIM driver unit
! When running this example in simulation
! other DMM errors ignored
DMM Set Function VDC ()
DMM Measure (TestResult)
```

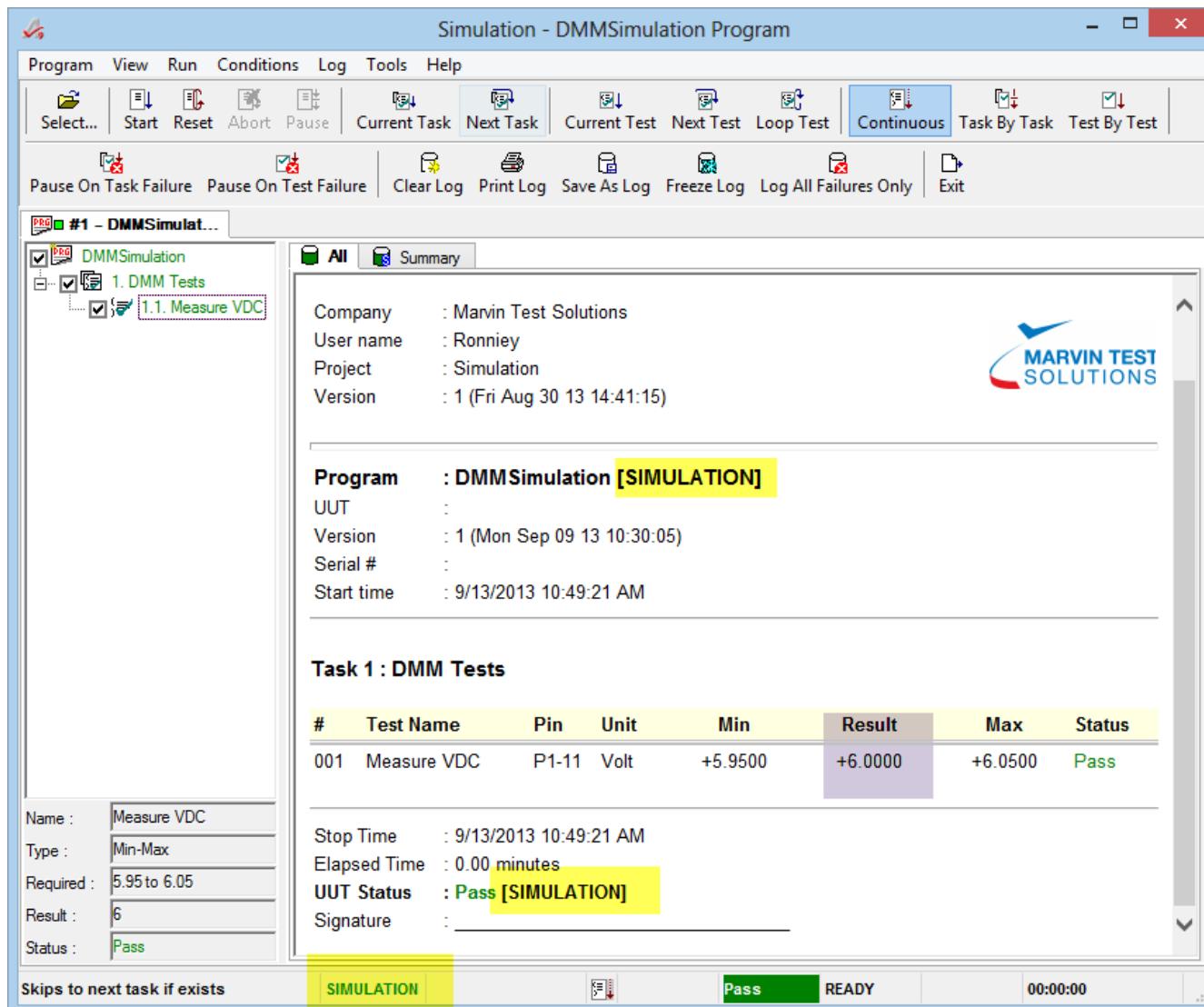
To the right, the "Simulation.drv" window shows the implementation code for the "OnSimulate" event. The code handles simulated procedure calls for various modules like DMM and Language, returning specific values or traces.

```
Events: OnSimulate(obModule, procCallee, penSimulateStatus): Variant Public
Occurs when a simulated procedure or IOTable is called
Name / Type
obModule Val Object
procCallee Val Procedure
penSimulateStatus Var Internal.enumSimulateStatus
dMultiplier Double
i Long

sModule=obModule.name
select sModule
case "DMM"
    sProc=procCallee
    select sProc
    case "DMM.Measure"
        p=GetSimulateParameter("pdResult")
        p=6.0
    case "DMM.GetSystemIdentification"
        p=GetSimulateParameter("psID")
        p="34401A"
    endselect
    trace sProc ! trace all DMM calls
    penSimulateStatus=enSimulateDone
case "Language"
    sProc=procCallee
    select sProc
    case "Language.User32.GetSystemMetrics"
        ! language test 7.1
        if Test.Id="User32"
            p=GetSimulateParameter("smIndex")
            lIndex=p
            if lIndex=0 or lIndex=1
                vrReturn=1024
            endif
            trace sProc ! trace specific calls
            penSimulateStatus=enSimulateDone
        endselect
    return vrReturn
```

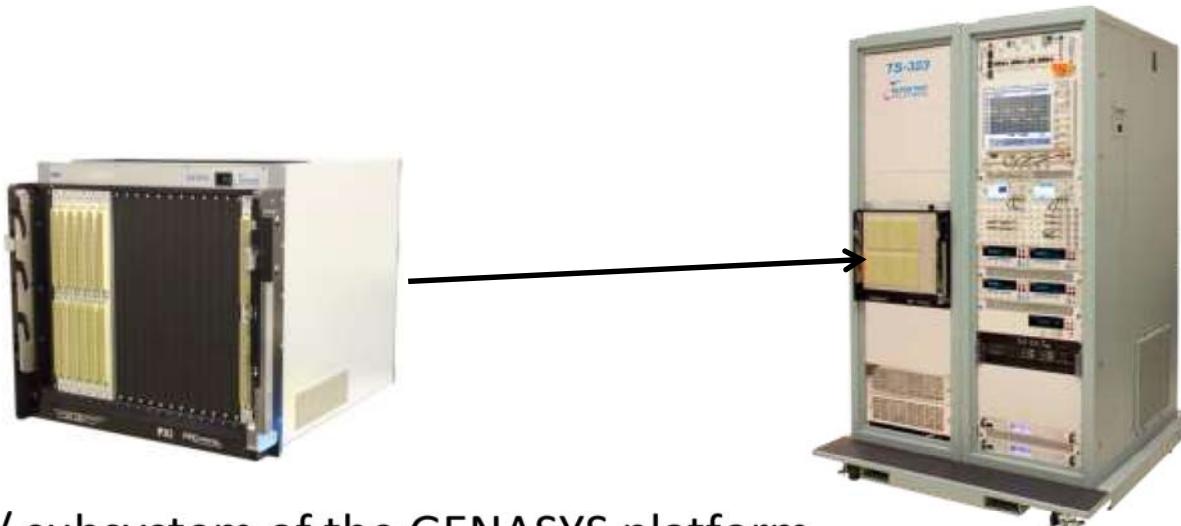
Simulation In Action – Test Executive

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GENASYS Switching Subsystem

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- Key component / subsystem of the GENASYS platform
- Innovative switching subsystem provides a hybrid-pin and “any resource to any pin” architecture
- Scalable system supports a minimum of 128 multiplexed hybrid pins, can be configured to support over 4500 interface pins
- Direct connect implementation interfaces all switching cards directly to the receiver interface, eliminating thousands of wires

GENASYS Switching Subsystem

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- GX7016 switching chassis with integrated MacPanel Scout receiver
 - 20 slot PXI chassis
 - Scout receiver & switch routing infrastructure
- Accommodates up to 18 “direct connect” switch cards
 - High density connection interface with no cabling
 - Internal, 16 wire analog bus with switch fabric to minimize stubbing
 - Compatible with a wide range of digital and analog resources



GX7016 Switching Chassis

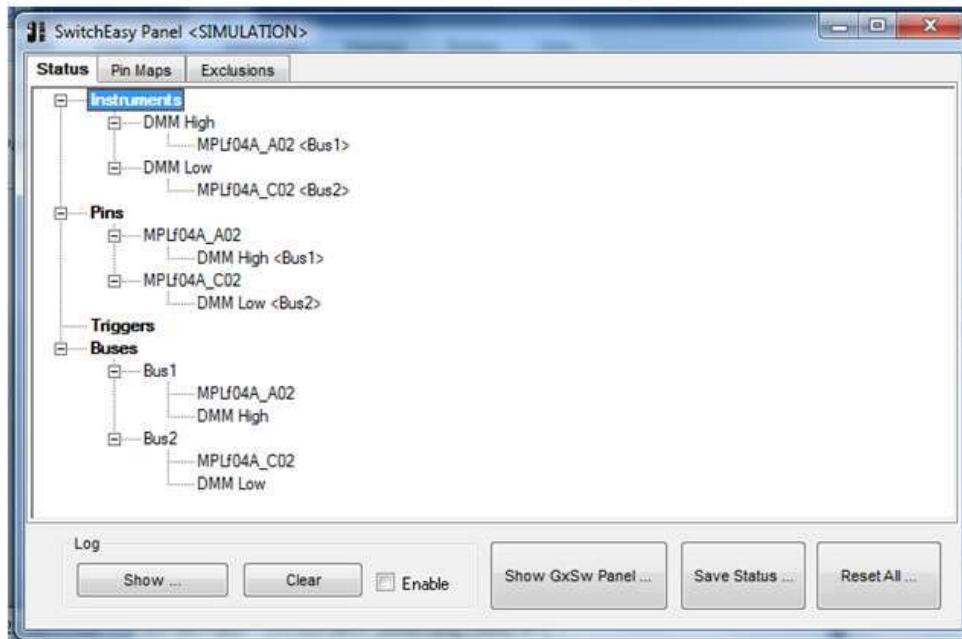


GENASYS Switch Card

GENASYS Switching Software - SwitchEasy

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- Signal routing management tool
 - End to end signal routing with deterministic switching and switch path management
 - Simplifies programming with Resource-to-Receiver Pin and Resource-To-UUT Pin commands
- Seamless integration with ATEasy test development / test executive software
- Reports total number of relay operations for all switching cards (values are stored in non-volatile memory on each card)



- Simulation is a powerful testing, debugging and analysis tool
- Simulation increase productivity of test engineers and system resource
- Need for a Run-Time access to implement simulation
- Simple design encourage usage and improve quality